

850V N-Channel Depletion-Mode Power MOSFET

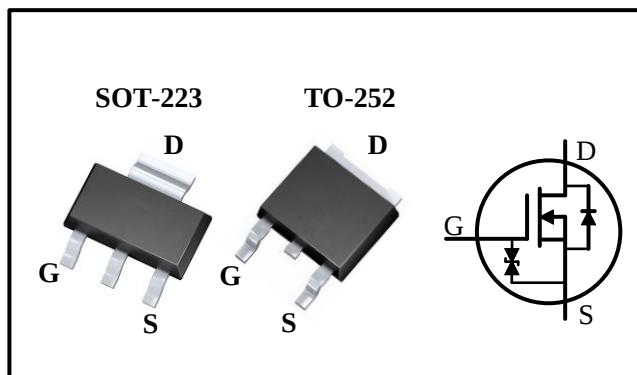
General Features

- Depletion Mode (Normally-on)
- ESD Improved Capability
- Fast Switching Speed
- High Breakdown Voltage: 850V
- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- RoHS Compliant
- Halogen-free Available

BV_{DSX}	$R_{DS(ON)}(Typ.)$	$I_{DSS}(Min.)$
850V	15Ω	200mA

Applications

- Audio Amplifiers
- Start-up Circuits
- Protection Circuits
- Ramp Generators
- Current Regulators
- Active Loads



Ordering Information

Part Number	Package	Marking	Remark
DMS8515E	SOT-223	8515	Halogen Free
DMD8515E	TO-252	8515	Halogen Free

Absolute Maximum Ratings

$T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	DMS8515E	DMD8515E	Unit
V _{DSX}	Drain-to-Source Voltage ^[1]	850		V
I _D	Continuous Drain Current	0.2	1	A
I _{DM}	Pulsed Drain Current ^[2]	0.8	3	
P _D	Power Dissipation	1.5	36	W
V _{GS}	Gate-to-Source Voltage	±20		V
T _L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300		°C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	DMS8515E	DMD8515E	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	83	3.47	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics

OFF Characteristics

 $T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSX}	Drain-to-Source Breakdown Voltage	850	--	--	V	$V_{GS}=-10\text{V}$, $I_D=250\mu\text{A}$
$I_{D(OFF)}$	Drain-to-Source Leakage Current	--	--	10	μA	$V_{DS}=850\text{V}$, $V_{GS}=-10\text{V}$
I_{GSS}	Gate-to-Source Leakage Current	--	--	20	μA	$V_{GS}=20\text{V}$, $V_{DS}=0\text{V}$
		--	--	-20		$V_{GS}=-20\text{V}$, $V_{DS}=0\text{V}$

ON Characteristics

 $T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_{DSS}	Saturated Drain-to-Source Current	200	--	--	mA	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	--	15	30	Ω	$V_{GS}=0\text{V}$, $I_D=200\text{mA}$ [3]
$V_{GS(OFF)}$	Gate-to-Source Cut-off Voltage	-4.0	--	-1.5	V	$V_{DS}=3\text{V}$, $I_D=8\mu\text{A}$
gfs	Forward Transconductance	--	720	--	mS	$V_{DS}=20\text{V}$, $I_D=200\text{mA}$

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
C_{iss}	Input Capacitance	--	393.4	--	pF	$V_{GS}=-10\text{V}$ $V_{DS}=50\text{V}$ $f=1.0\text{MHz}$
C_{oss}	Output Capacitance	--	20.7	--		
C_{rss}	Reverse Transfer Capacitance	--	4.1	--		
Q_g	Total Gate Charge	--	13.6	--	nC	$V_{GS}=-10\text{V}\sim 10\text{V}$ $V_{DS}=150\text{V}$ $I_D=200\text{mA}$
Q_{gs}	Gate-to-Source Charge	--	4.0	--		
Q_{gd}	Gate-to-Drain (Miller) Charge	--	3.6	--		

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$t_{d(on)}$	Turn-on Delay Time	--	18.1	--	ns	$V_{GS}=-10\text{V}\sim 0\text{V}$ $V_{DD}=150\text{V}$ $I_D=200\text{mA}$ $R_G=10\Omega$
t_{rise}	Rise Time	--	10.5	--		
$t_{d(off)}$	Turn-off Delay Time	--	35.6	--		
t_{fall}	Fall Time	--	94.0	--		



DMS8515E/DMD8515E Provisional Datasheet

Source-Drain Diode Characteristics

$T_A=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
V_{SD}	Diode Forward Voltage	--	--	1.2	V	$I_{SD}=200\text{mA}$, $V_{GS}=-10\text{V}$

NOTE:

[1] $T_J=+25^{\circ}\text{C}$ to $+150^{\circ}\text{C}$.

[2] Repetitive rating, pulse width limited by maximum junction temperature.

[3] Pulse width $\leq 380\mu\text{s}$, duty cycle $\leq 2\%$.

Typical Characteristics

Figure 1. Maximum Power Dissipation vs. Case Temperature

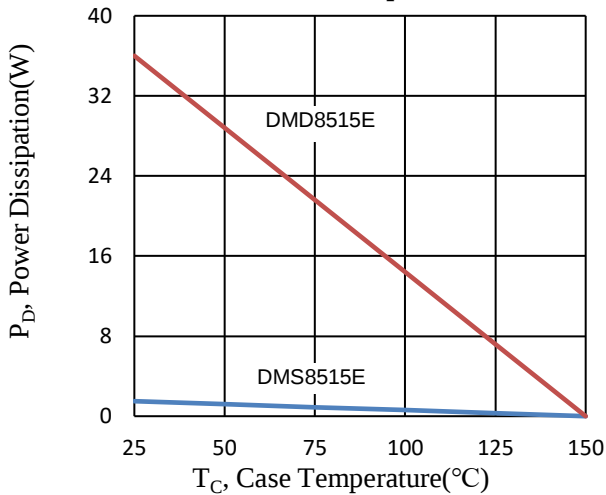


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

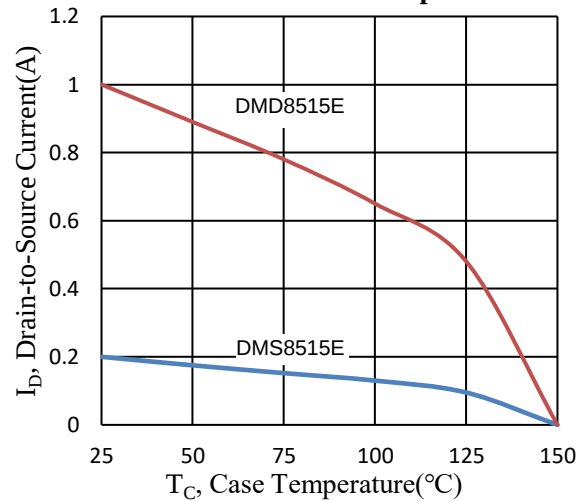


Figure 3. Typical Output Characteristics

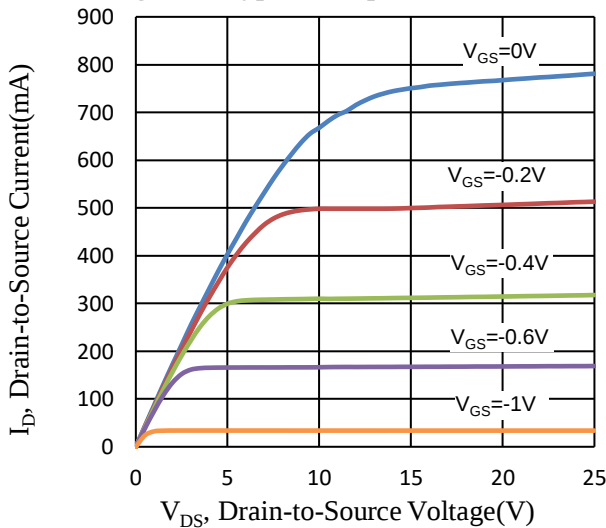


Figure 4. Typical Transfer Characteristics

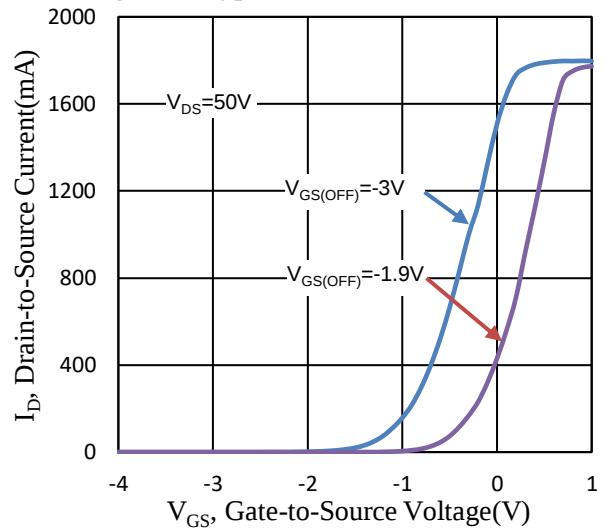


Figure 5. Typical Transfer Characteristics

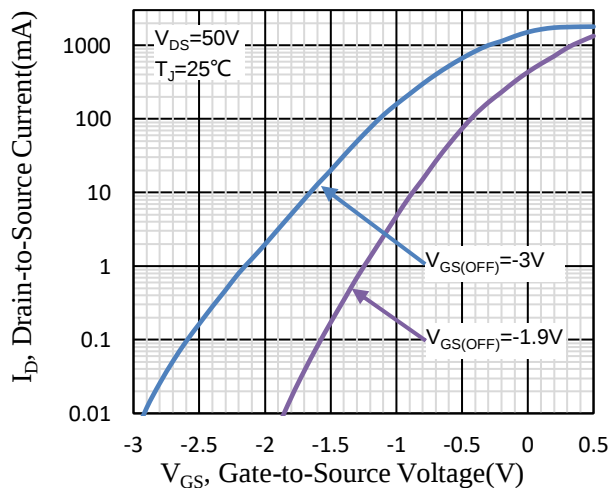


Figure 6. Typical Capacitance vs. Drain-to-Source Voltage

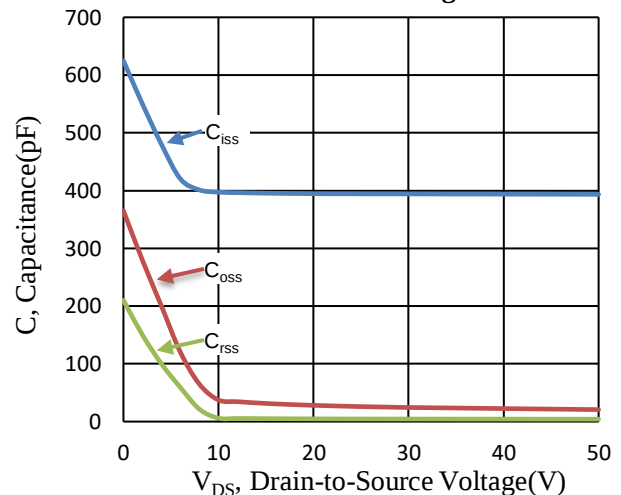


Figure 7. Typical Gate Charge vs. Gate-to-Source Voltage

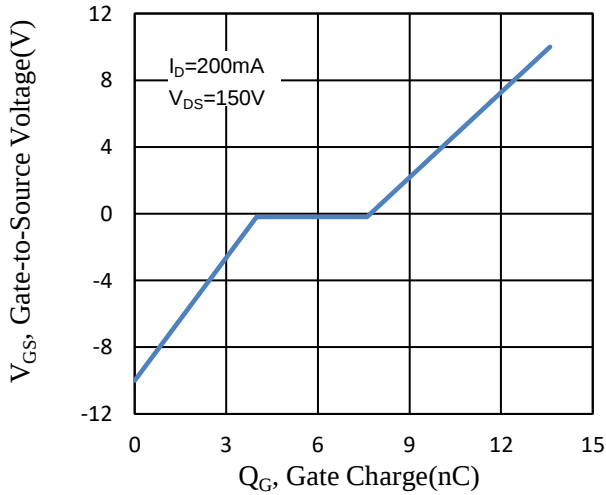


Figure 8. Normalized On-Resistance vs. Junction Temperature

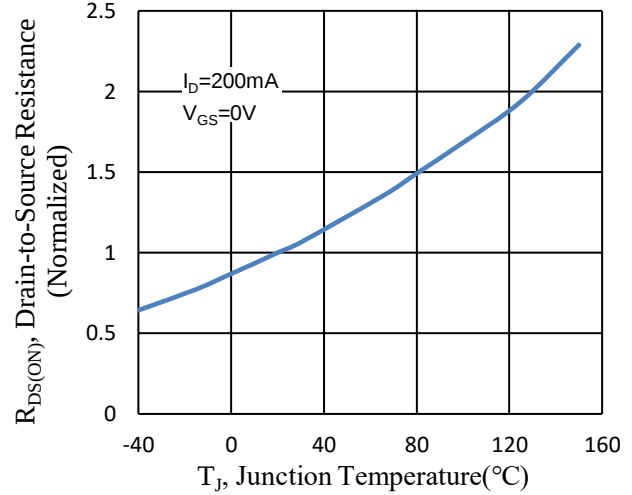


Figure 9. Gate-to-Source Cut-off Voltage vs. Junction Temperature

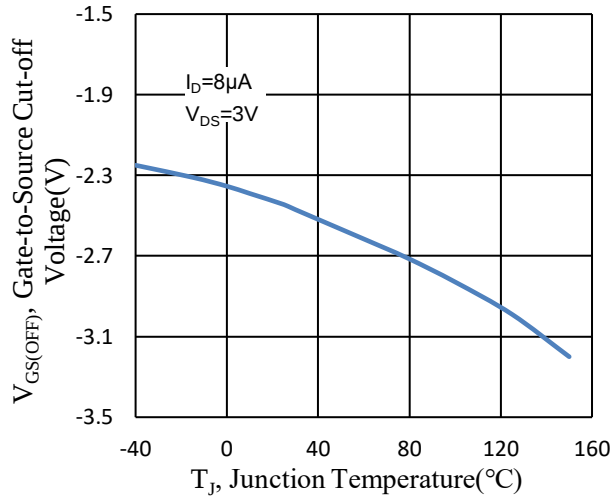


Figure 10. Drain-to-Source Breakdown Voltage vs. Junction Temperature

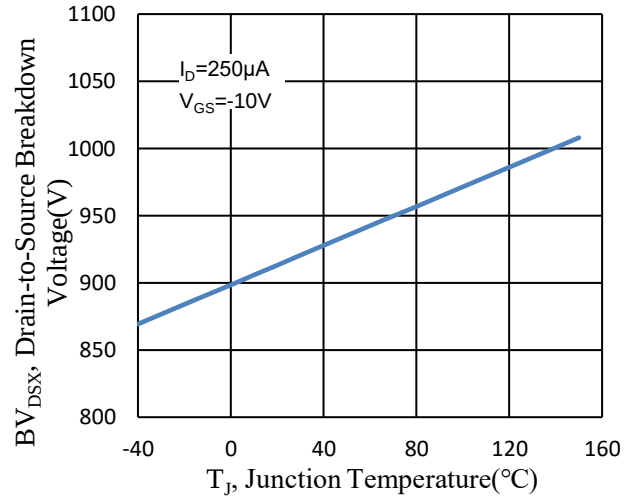
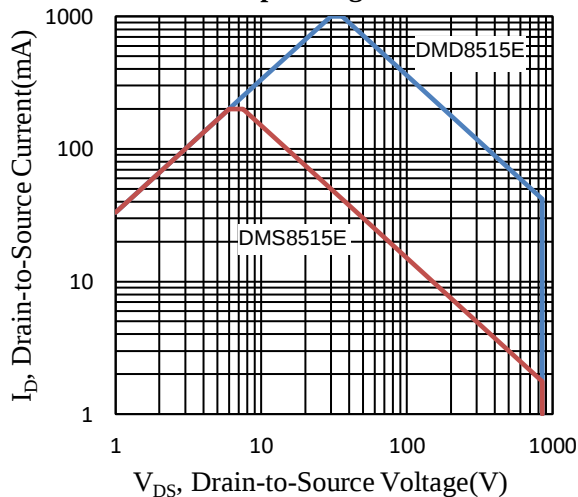
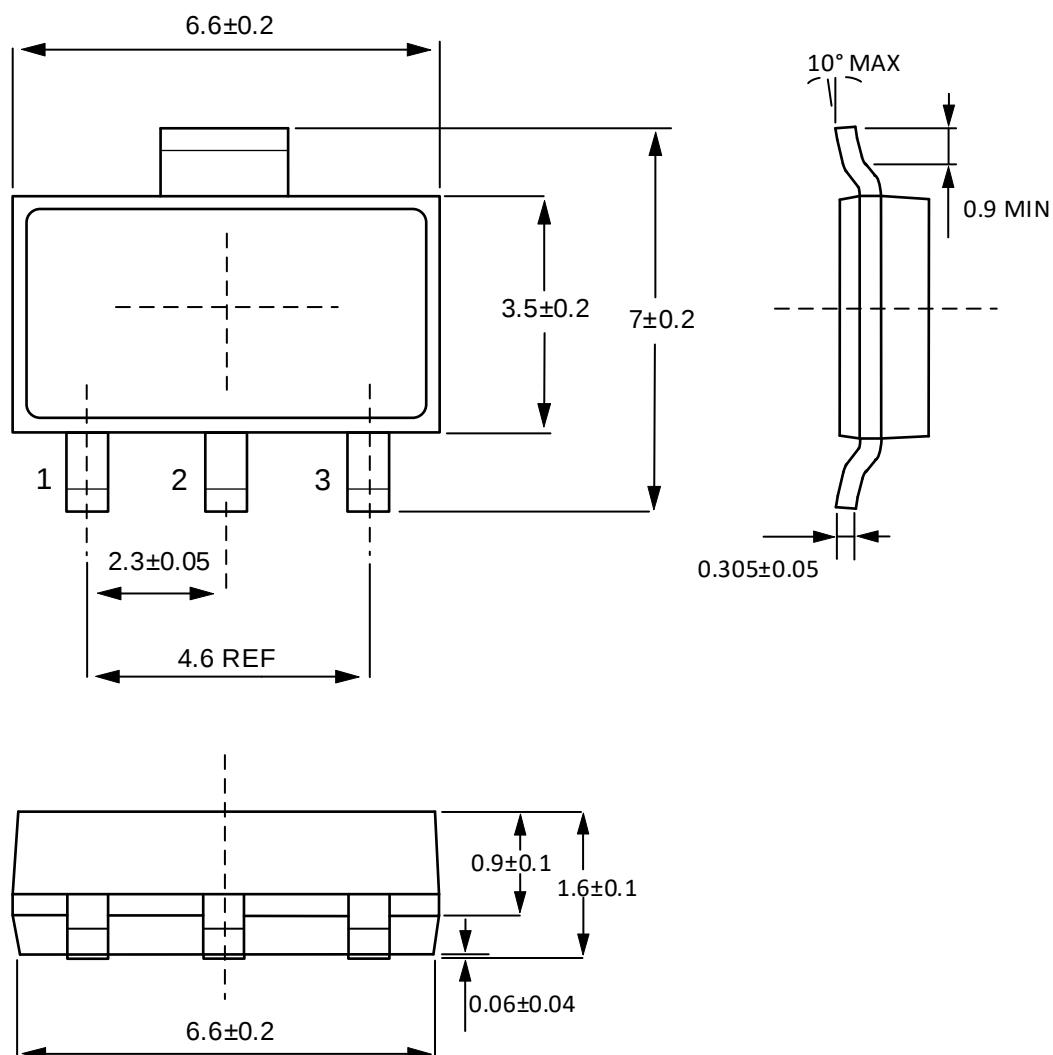


Figure 11. Maximum Forward Safe Operating Area

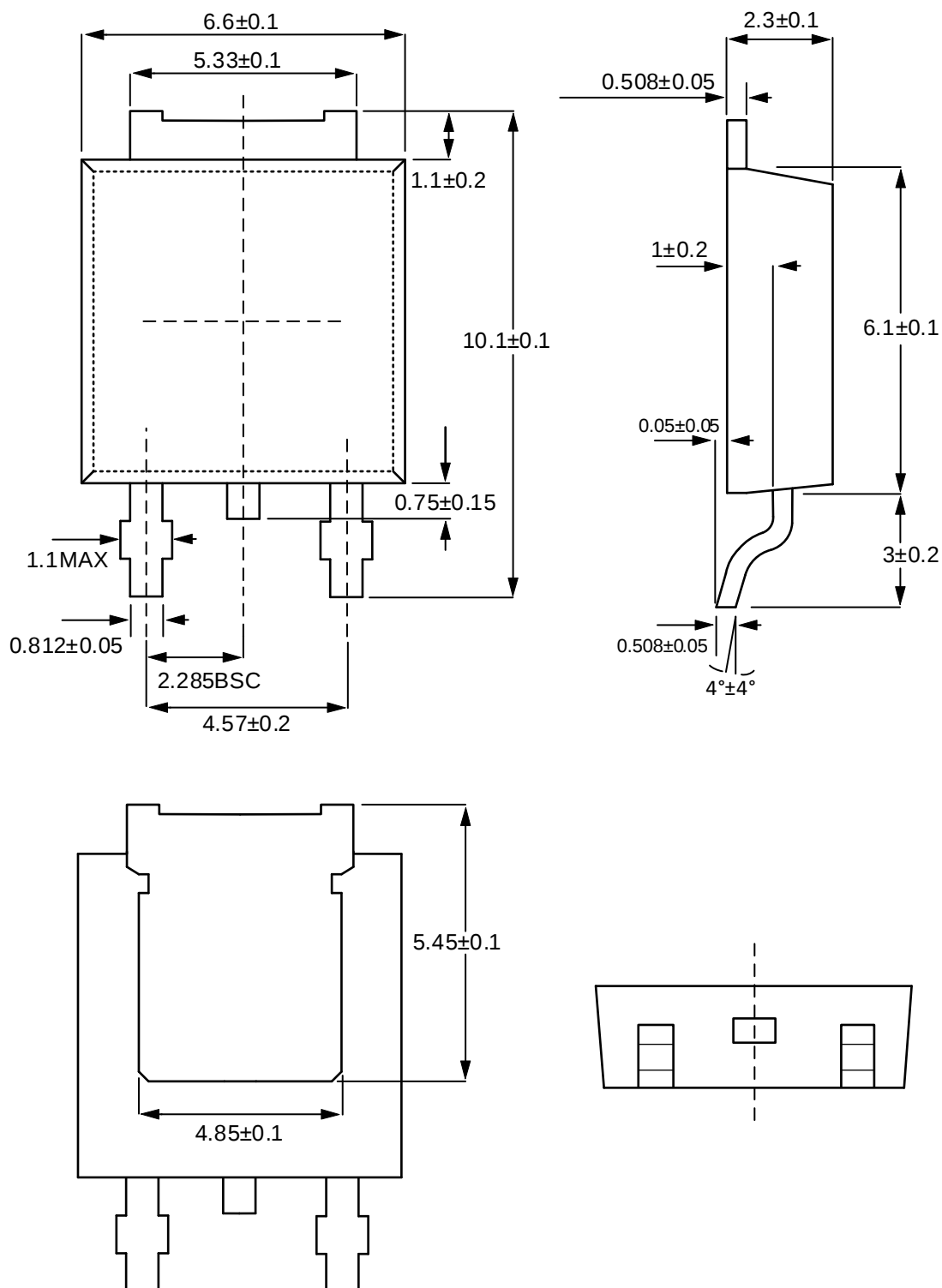


Package Dimensions

SOT-223



TO-252





Published by

ARK Microelectronics Co., Ltd.

ADD: D26, UESTC National Science Park No. 1 Shuangxing Avenue, Chengdu, Sichuan. All Rights Reserved.

Disclaimers

ARK Microelectronics Co., Ltd. reserves the right to make change without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to ARK Microelectronics Co., Ltd's terms and conditions supplied at the time of order acknowledgement.

ARK Microelectronics Co., Ltd. warrants performance of its hardware products to the specifications at the time of sale. Testing, reliability and quality control are used to the extent ARK Microelectronics Co., Ltd deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessary performed.

ARK Microelectronics Co., Ltd. does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using ARK Microelectronics Co., Ltd's components. To minimize risk, customers must provide adequate design and operating safeguards.

ARK Microelectronics Co., Ltd. does not warrant or convey any license either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in ARK Microelectronics Co., Ltd's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. ARK Microelectronics Co., Ltd is not responsible or liable for such altered documentation.

Resale of ARK Microelectronics Co., Ltd's products with statements different from or beyond the parameters stated by ARK Microelectronics Co., Ltd. for the product or service voids all express or implied warranties for the associated ARK Microelectronics Co., Ltd's product or service and is unfair and deceptive business practice. ARK Microelectronics Co., Ltd is not responsible or liable for any such statements.

Life Support Policy:

ARK Microelectronics Co., Ltd's products are not authorized for use as critical components in life devices or systems without the expressed written approval of ARK Microelectronics Co., Ltd.

As used herein:

1. Life support devices or systems are devices or systems which:
 - a. are intended for surgical implant into the human body,
 - b. support or sustain life,
 - c. whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.
-